

TEST REPORT

Report Number: R15541444-E12

Applicant : HID Global Corporation 611 Center Ridge Dr Austin, TX USA

- **Model : 30**
- FCC ID : JQ6-SIGNO30
 - **IC** : 2236B-SIGNO30
- EUT Description : Signo Décor Reader
- Test Standard(s) : FCC 47 CFR PART 1 SUBPART I FCC 47 CFR PART 2 SUBPART J OET BULLETIN NO. 65 IEEE C95.3 – 2021 ISED RSS-102 Issue 6

Date Of Issue: 2025-04-02

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Revision History

V1	2025-04-02	Initial Issue	Charles Moody
Rev.	lssue Date	Revisions	Revised By

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1. ATTESTATION OF TEST RESULTS

COMPANY NAME:	HID Global Corporation
	611 Center Ridge Dr
	Austin, TX USA

- **EUT DESCRIPTION:** Signo Décor Reader
- MODEL NUMBER: 30
- SERIAL NUMBER: Non-Serialized

SAMPLE RECEIPT DATE: 2024-11-19

DATE TESTED: 2025-03-24, 2025-03-28

APPLICABLE STANDARDS					
STANDARD	TEST RESULTS				
IEEE C95.3-2021	Complies				
OET BULLETIN NO. 65	Complies				
FCC 47 CFR PART 1 SUBPART I & PART 2 SUBPART J	Complies				
ISED RSS-102 Issue 6	Complies				

UL LLC tested the above equipment in accordance with the requirements set forth in the above standards. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. All samples tested were in good operating condition throughout the entire test program. Measurement Uncertainties are published for informational purposes only and were not taken into account unless noted otherwise.

This document may not be altered or revised in any way unless done so by UL LLC and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL LLC will constitute fraud and shall nullify the document.

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Approved & Released For UL LLC By:

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2. TEST METHODOLOGY

This report contains data provided by the customer which can impact the validity of results. UL LLC is only responsible for correctly integrating customer-provided data with measurements performed by UL LLC.

All testing / calculations were made in accordance with.

- FCC KDB 447498 D01 General RF Exposure Guidance v06
- FCC KDB 447498 D03 Supplement C Cross-Reference v01
- FCC Parts 1.1310, 2.1091, 2.1093, IEEE Std C95.1-2005, IEEE Std C95.3-2021
- RSS-102 Issue 6
- IC Safety Code 6

3. FACILITIES AND ACCREDITATION

UL LLC is accredited by A2LA, certification # 0751.06, for all testing performed within the scope of this report. Testing was performed at the locations noted below.

	Address	ISED CABID	ISED Company Number	FCC Registration
	Building: 12 Laboratory Dr RTP, NC 27709, U.S.A	1150067	2180C	825374
\boxtimes	Building: 2800 Perimeter Park Dr. Suite B Morrisville, NC 27560, U.S.A	030007	27265	023374

4. DECISION RULES AND MEASUREMENT UNCERTAINTY (RF EXPOSURE)

4.1. METROLOGICAL TRACEABILITY

All test and measuring equipment utilized to perform the tests documented in this report are calibrated on a regular basis, with a maximum time between calibrations of one year or the manufacturers' recommendation, whichever is less, and where applicable is traceable to recognized national standards.

4.2. DECISION RULES

The Decision Rule is based on Simple Acceptance in accordance with ISO Guide 98-4:2012 Clause 8.2. (Measurement uncertainty is not taken into account when stating conformity with a specified requirement.)

4.3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

PARAMETER	U _{Lab}
Magnetic Field Reading (A/m)	+/-0.3 dB
Electric Field Reading (V/m)	+/-0.3 dB

Uncertainty figures are valid to a confidence level of 95.45%.

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5. EQUIPMENT UNDER TEST

5.1. DESCRIPTION OF EUT

The EUT is a reader module that can be used for flush-mounted or inset reader designed to meet the security needs of an organization, while providing a sleek new design for various architectural and style requirements. This report covers the RF exposure testing of the 13.56 MHz RFID radio.

5.2. SOFTWARE AND FIRMWARE

EUT FW Version:R10.0.0.22EUT HW Version:B.1EUT Control SW Version:V1.3

5.3. WORST-CASE CONFIGURATION AND MODE

The following configurations were tested as worst-case position:

Config	Descriptions	Frequency
1	Tag Off	
2	Tag On (Centered)	13.56 MHz
3	(Offset to WC Positioning)	

Additionally, testing in five orientations at each of the three configurations were performed. These include edge top, edge right, edge left, edge bottom and front. Only the worst-case data per configuration is included in the report.

The EUT was tested in it's worst-case data rate, as provided by the manufacturer, of 106Kbps.

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5.4. DESCRIPTION OF TEST SETUP

	SUPPORT TEST EQUIPMENT						
Description Manufacturer Model Serial Number					FCC ID/ DoC		
Badge 13.56MHz		HID	N/A	NA		NA	
	I/O CABLES (RADIATED EMISSIONS)						
Cable No.	Port	# of Identical Ports	Connector Type	Cable Type	Cable Length (m)	Remarks	
1	Hardwired	1	Barrel	Unshielded	<3m	Used to power EUT	

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5.5. MEASUREMENT SETUP

The measurements were taken using a probe placed 20 cm surrounding the device for all configurations.

20cm distance E-field and H-field are evaluated from the center of the Narda probe.

For measurement setup and all testing photos, refer to external photos exhibit R15541444-EP2

6. TEST AND MEASUREMENT EQUIPMENT

The following test and measurement equipment was used for the tests documented in this report:

RTP probe

Test Equipment List							
Description	Manufacturer	Model	Label ID	Cal Due	Cal Date		
Electric and Magnetic Field Probe	Narda	EHP- 200AC	FA0001	2025-08-19	2024-08-19		
Thermometer - Digital	Control Company	14-650-118	168574	2026-05-31	2024-05-23		

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7. DUTY CYCLE

LIMITS

None; for reporting purposes only.

PROCEDURE

Zero-Span Spectrum Analyzer Method.

ON TIME AND DUTY CYCLE RESULTS

Test Engineer: 105900/84740

Configuration	Frequency (MHz)	ON Time	Period	Duty Cycle	Duty	Duty Cycle
		В		x	Cycle	Correction Factor
		(msec)	(msec)	(linear)	(%)	(dB)
1	13.56	30.00	96.75	0.31	31.01	NA
2	13.56	250.00	1590.00	0.16	15.72	NA
3	13.56	245.00	1585.00	0.15	15.46	NA



8. MAXIMUM PERMISSIBLE RF EXPOSURE

8.1. FCC LIMITS AND SUMMARY

§1.1310 The criteria listed in Table 1 shall be used to evaluate the environmental impact of human exposure to radiofrequency (RF) radiation as specified in §1.1307(b), except in the case of portable devices which shall be evaluated according to the provisions of §2.1093 of this chapter.

Table 1 to § 1.1310(e)(1) - Limits for Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)	
(i) Limits for C	Occupational/Controlle	d Exposure			
0.3-3.0	614	1.63	*(100)	≤6	
3.0-30	1842/f	4.89/f	*(900/f ²)	<6	
30-300	61.4	0.163	1.0	<6	
300-1,500			f/300	<6	
1,500-100,000			5	<6	
(ii) Limits for General Population/Uncontrolled Exposure					
0.3-1.34	614	1.63	*(100)	<30	
1.34-30	824/f	2.19/f	*(180/f ²)	<30	
30-300	27.5	0.073	0.2	<30	
300-1,500			f/1500	<30	
1,500-100,000			1.0	<30	

f = frequency in MHz. * = Plane-wave equivalent power density.

Using the table above, the limits for uncontrolled exposure to 13.56 MHz RFID radio is 60.77 V/m and 0.16 A/m.

RESULT:

Test Engineer:	105900/84740	Test Date:	2025-03-24

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8.2. IC LIMITS

Radio Standards Specification 102, Issue 5 Radio Frequency (RF) Exposure Compliance of Radio communication Apparatus (All Frequency Bands), sets out the requirements and measurement techniques used to evaluate radio frequency (RF) exposure compliance of radio communication apparatus designed to be used within the vicinity of the human body

The electric and magnetic field strength reference levels, power density reference levels, and associated reference period for devices employed by the general public (uncontrolled environment) and controlled-use devices (controlled environment) are specified in table 7 and table 8. Note that the power density limits specified in these tables apply to whole body exposure conditions.

Table 7: RF field strength and power density limits for devices used by the general public (uncontrolled environment)

Frequency range (MHz)	Electric field (V _{RMS} /m)	Magnetic field (A _{RMS} /m)	Power density (W/m²)	Reference period (minutes)
10-20	27.46	0.0728	2	6
20-48	58.07 / f ^{0.25}	0.1540 / <i>f</i> ^{0.25}	8.944 / f ^{0.5}	6
48-300	22.06	0.05852	1.291	6
300-6000	3.142 <i>f</i> ^{0.3417}	0.008335 <i>f</i> ^{0.3417}	0.02619 <i>f</i> ^{0.6834}	6
6000-15000	61.4	0.163	10	6
15000-150000	61.4	0.163	10	616000/ <i>f</i> ^{1.2}
150000-300000	0.158 <i>f</i> ^{0.5}	4.21×10 ⁻⁴ f ^{0.5}	6.67×10 ⁻⁵ f	616000/ <i>f</i> ^{1.2}

Note: *f* is frequency in MHz.

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8.2.1. MAXIMUM RESULT SUMMARY RF EXPOSURE (FCC)

CONFIGURATION 1: TAG OFF

E	Electric Field Limit		Magnetic Field Limit				
FCC RF	Maximum	Percentage	FCC RF	Maximum	Percentage		
Exposure Limit	Average (V/m)	(%)	Exposure	xposure Average (A/m) (%)			
(V/m)			(A/m)				
60.77	1.80	2.96%	0.16	0.02	12.5%		

CONFIGURATION 2: TAG ON (CENTERED)

E	Electric Field Limit		Magnetic Field Limit				
FCC RF	Maximum	Percentage	FCC RF	Maximum	Percentage		
Exposure Limit	Average (V/m)	(%)	Exposure Average (A/m) (%)				
(V/m)			(A/m)				
60.77	1.36	2.24%	0.16	0.01	6.25%		

CONFIGURATION 3: TAG ON (OFFSET)

E	Electric Field Limit		Magnetic Field Limit					
FCC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	FCC RF Exposure (A/m)	Maximum Average (A/m)	Percentage (%)			
60.77	0.96	1.58%	0.16	0.02	12.5%			

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8.2.2. MAXIMUM RESULT SUMMARY RF EXPOSURE (RSS 102)

CONFIGURATION 1: TAG OFF

E	Electric Field Limit		Magnetic Field Limit				
IC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	IC RF Exposure Limit (A/m)	Maximum Average (A/m)	Percentage (%)		
27.46	1.80	6.55%	0.0728	0.02	27.47%		

CONFIGURATION 2: TAG ON (CENTERED)

E	Electric Field Limit		Magnetic Field Limit				
IC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	IC RF Exposure Limit (A/m)	Maximum Average (A/m)	Percentage (%)		
27.46	1.36	4.95%	0.0728	0.01	13.74%		

CONFIGURATION 3: TAG ON (OFFSET)

E	Electric Field Limit		Magnetic Field Limit				
IC RF Exposure Limit (V/m)	Maximum Average (V/m)	Percentage (%)	IC RF Exposure Limit (A/m)	Maximum Average (A/m)	Percentage (%)		
27.46	0.96	3.50%	0.0728	0.02	27.47%		

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8.2.3. E- FIELD AND H- FIELD MEASUREMENTS (FCC)

Note: Peak measurements were performed. RMS values were calculated from the peak measurement. Please refer to the formula for calculating the RMS values: [Field Strength x $\sqrt{Duty Cycle}$].

CONFIGURATION 1: TAG OFF

Configuration Test Mo	Test Mode	ode Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
				Тор	3.23	8.23 2.82 2.41 24.04	1.80		Тор	0.02		0.01
				Right	2.82		1.57	0.16	Right	0.02		0.01
1	NIA	20	60.77	Bottom	2.41		1.34		Bottom	0.03	21.01	0.02
1	INA	20	00.77	Left	2.71	31.01	1.51		Left	0.02	31.01	0.01
				Front	2.62	2.62	1.46		Front	0.04		0.02
			Max	3.23		1.80	1	Max	0.04		0.02	

CONFIGURATION 2: TAG ON (CENTERED)

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	E	lectric Fie (V	eld Readin /m)	ıg	Magnetic Field Limit (A/m)	M	agnetic Fi (A	ield Readi /m)	ng
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
				Тор	3.44	3.44 3.13	1.36		Тор	0.02		0.01
				Right	3.13		1.24		Right	0.02		0.01
2	NIA	20	60.77	Bottom	2.92	15 70	1.16	0.16	Bottom	0.02	15 70	0.01
2	INA	20	00.77	Left	2.86	10.72	1.13	0.16	Left	0.02	10.72	0.01
				Front	2.61	2.61	1.03		Front	0.03		0.01
				Max	3.44		1.36		Max	0.03		0.01

CONFIGURATION 3: TAG ON (OFFSET)

Configuration Test Mod	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	E	lectric Fie (V	eld Readir /m)	ıg	Magnetic Field Limit (A/m)	M	agnetic Fi (A	ield Readi /m)	ng
			FCC	Location	Peak	Duty Cycle %	FCC Average	FCC	Location	Peak	Duty Cycle %	FCC Average
				Тор	2.45		0.96		Тор	0.02		0.01
				Right	2.43	0.96		Right	0.02		0.01	
2	NIA	20	60.77	Bottom	2.03	15.46	0.80	0.16	Bottom	0.02	15 46	0.01
3	INA	20	00.77	Left	2.33	2.33 2.34	0.92	0.10	Left	0.02	15.40	0.01
				Front	2.34		0.92		Front	0.04		0.02
				Max	2.45		0.96		Max	0.04		0.02

8.2.4. E- FIELD AND H- FIELD MEASUREMENTS (IC)

Note: Peak measurements were performed. RMS values were calculated from the peak measurement. Please refer to the formula for calculating the RMS values: [Field Strength x $\sqrt{Duty Cycle}$].

CONFIGURATION 1: TAG OFF

Configuration Te	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	E	lectric Fie (V	eld Readin /m)	g	Magnetic Field Limit (A/m)	Ma	agnetic Fi (A	ield Readi /m)	ng
			IC	Location	Peak	Duty Cycle %	IC Average	IC	Location	Peak	Duty Cycle %	IC Average
				Тор	3.23		1.80		Тор	0.02		0.01
				Right	2.82		1.57	0.0728	Right	0.02		0.01
4	NIA	20	07.46	Bottom		21.01	1.34		Bottom	0.03	21.01	0.02
1	INA	20	27.40	Left	2.71	31.01	1.51		Left	0.02	31.01	0.01
				Front	2.62	2.62	1.46		Front	0.04		0.02
				Max	3.23		1.80		Max	0.04		0.02

CONFIGURATION 2: TAG ON (CENTERED)

Configuration	Test Mode	Measuring e Distance (cm)	Electric Field Limit (V/m)	E	lectric Fie (V	eld Readin /m)	ıg	Magnetic Field Limit (A/m)	M	agnetic Fi (A	ield Readi /m)	ng
			IC	Location	Peak	Duty Cycle %	IC Average	IC	Location	Peak	Duty Cycle %	IC Average
			Тор	3.44		1.36		Тор	0.02		0.01	
				Right	3.13	3.13	1.24	0.0700	Right	0.02		0.01
n	NIA	20	27.46	Bottom	2.92	15 70	1.16		Bottom	0.02	15 70	0.01
2	INA	20	27.40	Left	2.86	10.72	1.13	0.0720	Left	0.02	10.72	0.01
				Front	2.61	.61	1.03]	Front	0.03		0.01
				Max	3.44		1.36		Max	0.03		0.01

CONFIGURATION 3: TAG ON (OFFSET)

Configuration	Test Mode	Measuring Distance (cm)	Electric Field Limit (V/m)	Electric Field Reading (V/m)				Magnetic Field Limit (A/m)	Magnetic Field Reading (A/m)			
			IC	Location	Peak	Duty Cycle %	IC Average	IC	Location	Peak	Duty Cycle %	IC Average
3	NA	20	27.46	Тор	2.45	15.46	0.96	0.0728	Тор	0.02	15.46	0.01
				Right	2.43		0.96		Right	0.02		0.01
				Bottom	2.03		0.80		Bottom	0.02		0.01
				Left	2.33		0.92		Left	0.02		0.01
				Front	2.34		0.92		Front	0.04		0.02
				Max	2.45		0.96		Max	0.04		0.02

9. RF EXPOSURE TEST SETUP AND SETUP PHOTO

For measurement setup and all testing photos, refer to external photos exhibit R15541444-EP2

END OF REPORT